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TDA7566

4 x 40 W multifunction quad power amplifier with built-in diagnostics features

Features

- DMOS power output
- High output power capability 4 x 25 W/4 Ω @ 14.4 V, 1 kHz, 10 % THD, 4 x 40 W max. power
- Max. output power 4 x 60 W/2 Ω
- Full I²C bus driving:
 - Standby
 - Independent front/rear soft play/mute
 - Selectable gain 26 dB 12 dB
 - I²C bus digital diagnostics
- Full fault protection
- DC offset detection
- Four independent short circuit protection
- Clipping detector pin with selectable threshold (1%, 10%)
- ESD protection

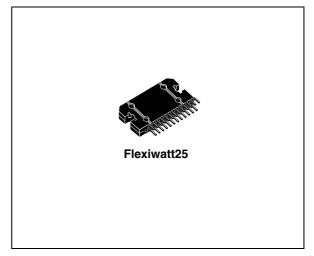
Description

The TDA7566 is a new BCD technology quad bridge type of car radio amplifier in Flexiwatt25 package specially intended for car radio applications.

Table 1. Device summary

| Order code | Package | Packing |
|------------------------|-------------|---------|
| E-TDA7566 | Flexiwatt25 | Tube |
| TDA7566 ⁽¹⁾ | Flexiwatt25 | Tube |

1. Obsolete product.



Thanks to the DMOS output stage the TDA7566 has a very low distortion allowing a clear powerful sound.

This device is equipped with a full diagnostics array that communicates the status of each speaker through the l^2C bus.

The possibility to control the configuration and behavior of the device by means of the I^2C bus makes TDA7566 a very flexible product.

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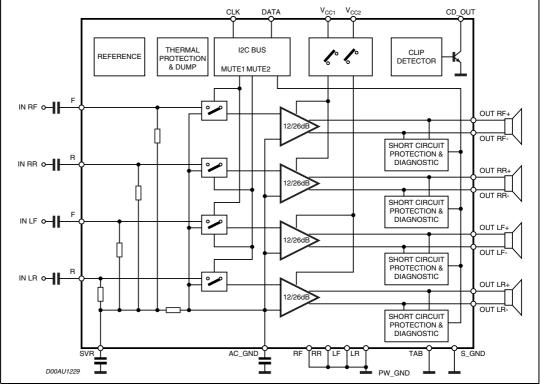
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1 Block diagram and application and test circuit

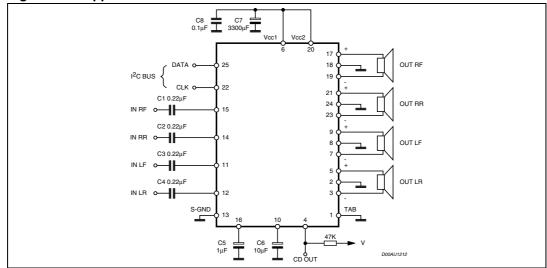
1.1 Block diagram

Figure 1. Block diagram



1.2 Application and test circuit

Figure 2. Application and test circuit

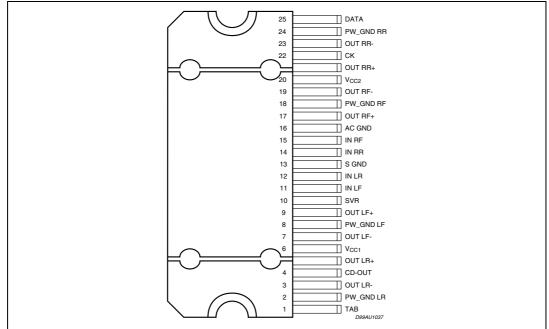




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2 Pin description

| Figure 3. | Pin connection (top view) |
|-----------|---------------------------|
|-----------|---------------------------|





3 Electrical specifications

3.1 Absolute maximum ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|-----------------------------------|--|------------|------|
| V _{op} | Operating supply voltage | 18 | V |
| Vs | DC supply voltage | 28 | V |
| V _{peak} | Peak supply voltage (for t = 50 ms) | 50 | V |
| V _{CK} | CK pin voltage | 6 | V |
| V _{DATA} | Data pin voltage | 6 | V |
| Ι _Ο | Output peak current (not repetitive t = 100 μ s) | 8 | Α |
| Ι _Ο | Output peak current (repetitive f > 10 Hz) | 6 | Α |
| P _{tot} | Power dissipation T _{case} = 70 °C | 85 | W |
| T _{stg} , T _j | Storage and junction temperature | -55 to 150 | °C |

3.2 Thermal data

Table 3. Thermal data

| Symbol | Description | Value | Unit |
|------------------------|--|-------|------|
| R _{th j-case} | Thermal resistance junction-to-case Max. | 1 | °C/W |

3.3 Electrical characteristics

Table 4.Electrical characteristics

(Refer to the test circuit, V_S = 14.4 V; R_L = 4 Ω ; f = 1 kHz; G_V = 26 dB; T_{amb} = 25 °C; unless otherwise specified.)

| Symbol | Parameter | Test condition | | Тур. | Max. | Unit | | |
|-----------------|-------------------------------|---|----------------------|----------------------|------|-------------|--|--|
| Power amplifier | | | | | | | | |
| Vs | Supply voltage range | - | 8 | - | 18 | V | | |
| l _d | Total quiescent drain current | - | - | 150 | 300 | mA | | |
| | Output power | Max. (V _S = 14.4 V) | 35 | 40 | - | W | | |
| | | THD = 10 % THD = 1 % | 22 16 | 25 20 | - | W W | | |
| P _O | | $R_{L} = 2 Ω; EIAJ (V_{S} = 13.7 V)$ $R_{L} = 2 Ω; THD 10 %$ $R_{L} = 2 Ω; THD 1 %$ $R_{L} = 2 Ω; MAX POWER$ | 50 32 25 55 | 55 38 30 60 | - | W W W | | |



Table 4. Electrical characteristics (continued)

(Refer to the test circuit, $V_S = 14.4 \text{ V}$; $R_L = 4 \Omega$; f = 1 kHz; $G_V = 26 \text{ dB}$; $T_{amb} = 25 \text{ °C}$; unless otherwise specified.)

| Symbol | Parameter | Test condition | Min. | Тур. | Max. | Unit |
|-------------------|--|---|---------|------|---------|------|
| | | P _O = 1 W to 10 W | - | 0.04 | 0.1 | % |
| THD | Total harmonic distortion | $G_V = 12 \text{ dB};$ V _O = 0.1 to 5 V _{RMS} | - | 0.02 | 0.05 | % |
| C _T | Cross talk | f = 1 kHz to 10 kHz, $R_G = 600 W$ | 50 | 60 | - | dB |
| R _{IN} | Input impedance | - | 60 | 100 | 130 | KΩ |
| G _{V1} | Voltage gain 1 | - | 25 | 26 | 27 | dB |
| ΔG_{V1} | Voltage gain match 1 | - | -1 | 0 | 1 | dB |
| G _{V2} | Voltage gain 2 | - | - | 12 | - | dB |
| E _{IN1} | Output noise voltage 1 | R_g = 600 Ω; 20 Hz to 22 kHz | - | 35 | 100 | μV |
| E _{IN2} | Output noise voltage 2 | $R_g = 600 \Omega;$ G _V = 12 dB; 20 Hz to 22 kHz | - | 12 | - | μV |
| SVR | Supply voltage rejection | f = 100 Hz to 10 kHz; V _r = 1V pk; R _g = 600 Ω | 50 | 60 | - | dB |
| BW | Power bandwidth | - | 100 | - | - | KHz |
| A _{SB} | Standby attenuation | - | 90 | 110 | - | dB |
| I _{SB} | Standby current | - | - | 25 | 100 | μA |
| A _M | Mute attenuation | - | 80 | 100 | - | dB |
| V _{OS} | Offset voltage | Mute and Play | -100 | 0 | 100 | mV |
| V _{AM} | Min. supply voltage threshold | - | 7 | 7.5 | 8 | V |
| T _{ON} | Turn on delay | D2/D1 (IB1) 0 to 1 | - | 20 | 50 | ms |
| T _{OFF} | Turn off delay | D2/D1 (IB1) 1 to 0 | - | 20 | 50 | ms |
| CD _{LK} | Clip det high leakage current | CD off | - | 0 | 15 | μA |
| CD _{SAT} | Clip det sat. voltage | CD on; I _{CD} = 1mA | - | - | 300 | mV |
| | Clip dat THD laval | D0 (IB1) = 0 | 0 | 1 | 2 | % |
| CD _{THD} | Clip det THD level | D0 (IB1) = 1 | 5 | 10 | 15 | % |
| Turn on c | liagnostics 1 (Power amplifier me | ode) | | | | |
| Pgnd | Short to GND det. (below this limit, the Output is considered in Short Circuit to GND) | | - | - | 1.2 | V |
| Pvs | Short to Vs det. (above this limit, the Output is considered in Short Circuit to VS) | Power amplifier in standby | Vs -1.2 | - | - | V |
| Pnop | Normal operation thresholds.(Within these limits, the Output is considered without faults). | | 1.8 | - | Vs -1.8 | V |



Table 4. Electrical characteristics (continued)

(Refer to the test circuit, $V_S = 14.4 \text{ V}$; $R_L = 4 \Omega$; f = 1 kHz; $G_V = 26 \text{ dB}$; $T_{amb} = 25 \text{ °C}$; unless otherwise specified.)

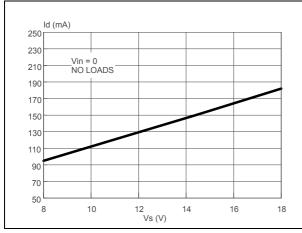
| Symbol | Parameter | Test condition | Min. | Тур. | Max. | Unit |
|-------------------------|--|--|---------|------|---------|------|
| Lsc | Shorted load det. | - | - | - | 0.5 | Ω |
| Lop | Open load det. | - | 85 | - | - | Ω |
| Lnop | Normal load det. | - | 1.65 | - | 45 | Ω |
| Turn on c | liagnostics 2 (Line driver mode) | | | | | |
| Pgnd | Short to GND det. (below this limit, the Output is considered in Short Circuit to GND) | | - | - | 1.2 | V |
| Pvs | Short to Vs det. (above this limit, the Output is considered in Short Circuit to VS) | Power amplifier in standby | Vs -1.2 | - | - | V |
| Pnop | Normal operation thresholds. (Within these limits, the Output is considered without faults). | | 1.8 | - | Vs -1.8 | V |
| Lsc | Shorted load det. | - | - | - | 2 | Ω |
| Lop | Open load det. | - | 330 | - | - | Ω |
| Lnop | Normal load det. | - | 7 | - | 180 | Ω |
| Permane | nt diagnostics 2 (Power amplifier | r mode or line driver mode) | | | | |
| Pgnd | Short to GND det. (below this limit, the Output is considered in Short Circuit to GND) | Power amplifier in Mute or Play, one or more short circuits protection activated | - | - | 1.2 | V |
| Pvs | Short to Vs det. (above this limit, the Output is considered in Short Circuit to VS) | - | Vs -1.2 | - | - | V |
| Pnop | Normal operation thresholds.(Within these limits, the Output is considered without faults). | - | 1.8 | - | Vs -1.8 | V |
| 1 | Shorter Load det. | Power amplifier mode | - | - | 0.5 | Ω |
| L _{SC} | Shorter Load det. | Line driver mode | - | - | 2 | Ω |
| V _O | Offset Detection | Power amplifier in play, AC Input signals = 0 | 1.5 | 2 | 2.5 | V |
| I _{NL} | Normal load current detection | | 500 | - | - | mA |
| I _{OL} | Open load current detection | V _O < (V _S - 5)pk | - | - | 250 | mA |
| l ² C bus ir | nterface | | I | | | |
| f _{SCL} | Clock frequency | - | - | 400 | - | KHz |
| V _{IL} | Input low voltage | - | - | - | 1.5 | V |
| V _{IH} | Input high voltage | - | 2.3 | - | - | V |



3.4 Electrical characteristics curves

Figure 4. Quiescent current vs. supply voltage





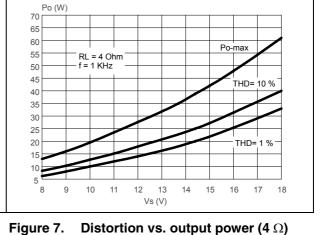


Figure 6. Output power vs. supply voltage (2Ω)

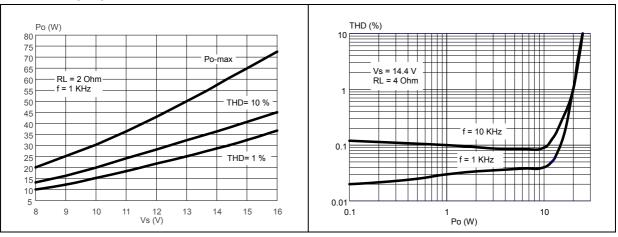
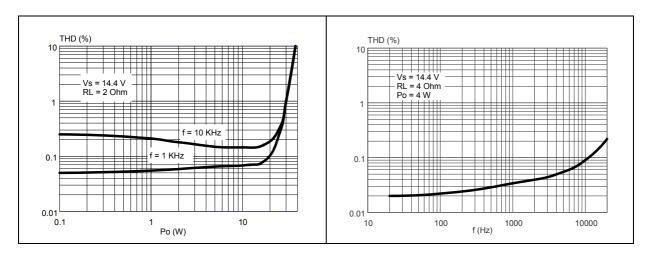


Figure 8. Distortion vs. output power (2 Ω)





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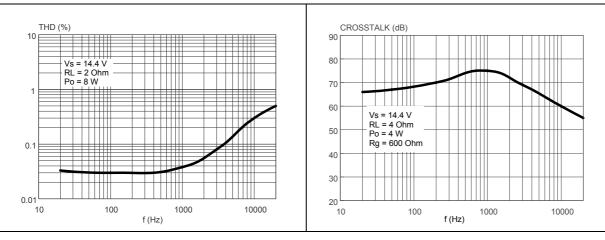


Figure 10. Distortion vs. frequency (2 Ω)



Figure 12. Supply voltage rejection vs. frequency

Figure 13. Power dissipation and efficiency vs. output power (4 Ω , Sine)

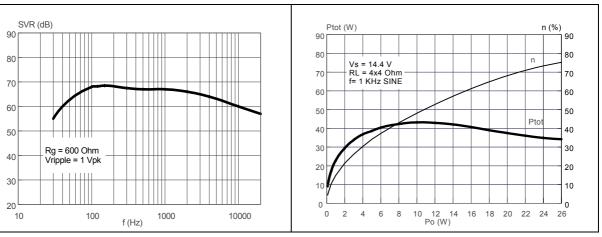
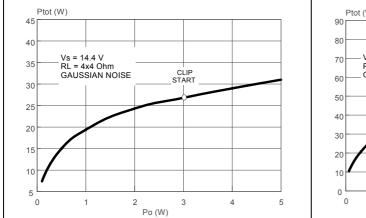
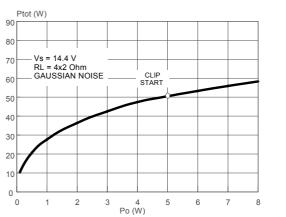


Figure 14. Power dissipation vs. average output Figure 15. power dissipation vs. average output power (audio program simulation, 4 Ω) Power dissipation vs. average output power (audio program simulation, 2 Ω)







Diagnostics functional description 4

Turn-on diagnostic 4.1

It is activated at the turn-on (standby out) under I²C bus request. Detectable output faults are:

- Short to GND
- Short to VS _
- Short across the speaker _
- Open speaker _

To verify if any of the above misconnections are in place, a subsonic (inaudible) current pulse (Figure 16) is internally generated, sent through the speaker(s) and sunk back. The Turn On diagnostic status is internally stored until a successive diagnostic pulse is requested (after a I²C reading).

If the "standby out" and "diag. enable" commands are both given through a single programming step, the pulse takes place first (power stage still in standby mode, low, outputs = high impedance).

Afterwards, when the Amplifier is biased, the PERMANENT diagnostic takes place. The previous Turn On state is kept until a short appears at the outputs.

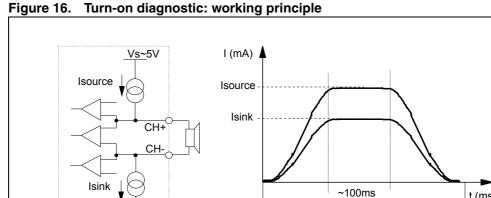


Figure 16. Turn-on diagnostic: working principle

Figure 17 and 18 show SVR and output waveforms at the turn-on (standby out) with and without Turn-on diagnostic.

Measure time



t (ms)

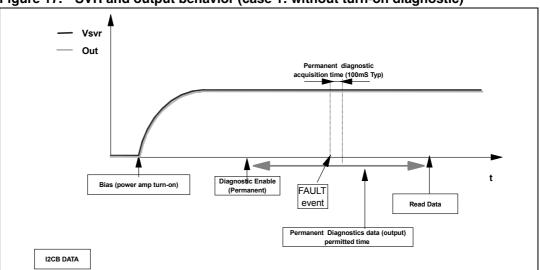
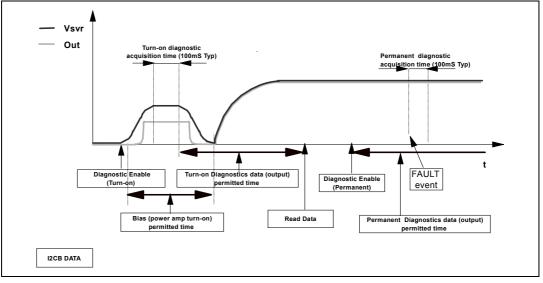


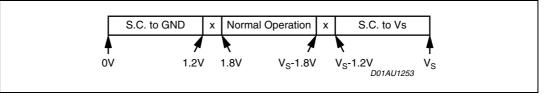
Figure 17. SVR and output behavior (case 1: without turn-on diagnostic)





The information related to the outputs status is read and memorized at the end of the current pulse top. The acquisition time is 100 ms (typ.). No audible noise is generated in the process. As for short to GND / Vs the fault-detection thresholds remain unchanged from 26 dB to 12 dB gain setting. They are as follows:

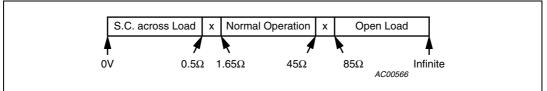
Figure 19. Thresholds for short to GND/V_{S}





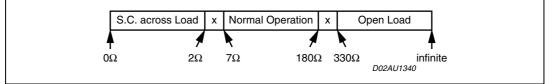
Concerning short across the speaker / open speaker, the threshold varies from 26 dB to 12 dB gain setting, since different loads are expected (either normal speaker's impedance or high impedance). The values in case of 26 dB gain are as follows:

Figure 20. Thresholds for short across the speaker/open speaker



If the Line-Driver mode (G_v = 12 dB and Line Driver Mode diagnostic = 1) is selected, the same thresholds will change as follows:

Figure 21. Thresholds for line-drivers



4.2 Permanent diagnostics

Detectable conventional faults are:

- short to GND
- short to Vs
- short across the speaker

The following additional features are provided:

- output offset detection
- AC diagnostic

The TDA7566 has 2 operating statuses:

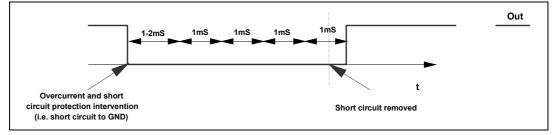
- Restart mode. The diagnostic is not enabled. Each audio channel operates independently from each other. If any of the a.m. faults occurs, only the channel(s) interested is shut down. A check of the output status is made every 1 ms (*Figure 22*). Restart takes place when the overload is removed.
- Diagnostic mode. It is enabled via I²C bus and self activates if an output overload (such to cause the intervention of the short-circuit protection) occurs to the speakers outputs. Once activated, the diagnostics procedure develops as follows (*Figure 23*):
 - To avoid momentary re-circulation spikes from giving erroneous diagnostics, a check of the output status is made after 1ms: if normal situation (no overloads) is detected, the diagnostic is not performed and the channel returns back active.
 - Instead, if an overload is detected during the check after 1 ms, then a diagnostic cycle having a duration of about 100 ms is started.
 - After a diagnostic cycle, the audio channel interested by the fault is switched to Restart mode. The relevant data are stored inside the device and can be read by the microprocessor. When one cycle has terminated, the next one is activated by

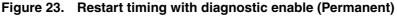


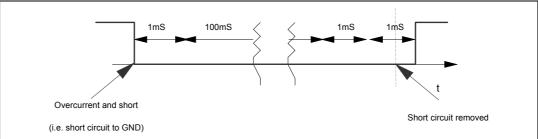
an I²C reading. This is to ensure continuous diagnostics throughout the car-radio operating time.

 To check the status of the device a sampling system is needed. The timing is chosen at microprocessor level (over half a second is recommended).

Figure 22. Restart timing without diagnostic enable (Permanent) each 1 ms time, a sampling of the fault is done







4.3 Output DC offset detection

Any DC output offset exceeding ± 2 V are signalled out. This inconvenient might occur as a consequence of initially defective or aged and worn-out input capacitors feeding a DC component to the inputs, so putting the speakers at risk of overheating.

This diagnostic has to be performed with low-level output AC signal (or $V_{in} = 0$).

The test is run with selectable time duration by microprocessor (from a "start" to a "stop" command):

START = Last reading operation or setting IB1 - D5 - (OFFSET enable) to 1

STOP = Actual reading operation

Excess offset is signalled out if persistent throughout the assigned testing time. This feature is disabled if any overloads leading to activation of the short-circuit protection occurs in the process.



4.4 AC diagnostic

It is targeted at detecting accidental disconnection of tweeters in 2-way speaker and, more in general, presence of capacitive (AC) coupled loads.

This diagnostic is based on the notion that the overall speaker's impedance (woofer + parallel tweeter) will tend to increase towards high frequencies if the tweeter gets disconnected, because the remaining speaker (woofer) would be out of its operating range (high impedance). The diagnostic decision is made according to peak output current thresholds, as follows:

 $I_{out} > 500 mApk = normal status$

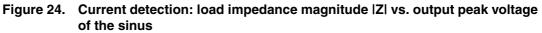
I_{out} < 250mApk = open tweeter

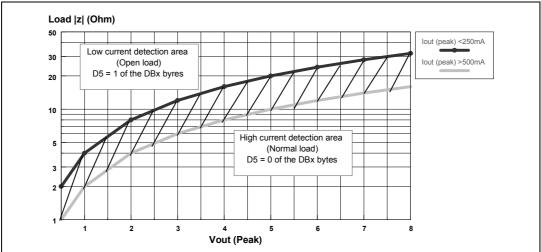
To correctly implement this feature, it is necessary to briefly provide a signal tone (with the amplifier in "play") whose frequency and magnitude are such to determine an output current higher than 500mApk in normal conditions and lower than 250mApk should the parallel tweeter be missing. The test has to last for a minimum number of 3 sine cycles starting from the activation of the AC diagnostic function IB2<D2>) up to the I²C reading of the results (measuring period). To confirm presence of tweeter, it is necessary to find at least 3 current pulses over 500mA over all the measuring period, else an "open tweeter" message will be issued.

The frequency / magnitude setting of the test tone depends on the impedance characteristics of each specific speaker being used, with or without the tweeter connected (to be calculated case by case). High-frequency tones (> 10 KHz) or even ultrasonic signals are recommended for their negligible acoustic impact and also to maximize the impedance module's ratio between with tweeter-on and tweeter-off.

Figure 24 shows the Load Impedance as a function of the peak output voltage and the relevant diagnostic fields.

This feature is disabled if any overloads leading to activation of the short-circuit protection occurs in the process.







4.5 Multiple faults

When more misconnections are simultaneously in place at the audio outputs, it is guaranteed that at least one of them is initially read out. The others are notified after successive cycles of I^2C reading and faults removal, provided that the diagnostic is enabled. This is true for both kinds of diagnostic (Turn on and Permanent).

The table below shows all the couples of double-fault possible. It should be taken into account that a short circuit with the 4 ohm speaker unconnected is considered as double fault.

| | S. GND (so) | S. GND (sk) | S. Vs | S. Across L. | Open L. | | | |
|--------------|-------------|-------------|-------------------|--------------|-------------|--|--|--|
| S. GND (so) | S. GND | S. GND | S. Vs + S. GND | S. GND | S. GND | | | |
| S. GND (sk) | / | S. GND | S. Vs | S. GND | Open L. (*) | | | |
| S. Vs | / | / | S. Vs | S. Vs | S. Vs | | | |
| S. Across L. | 1 | / | / | S. Across L. | N.A. | | | |
| Open L. | 1 | / | / | / | Open L. (*) | | | |

Table 5. Double fault table for turn-on diagnostic

S. GND (so) / S. GND (sk) in the above table make a distinction according to which of the 2 outputs is shorted to ground (test-current source side= so, test-current sink side = sk). More precisely, in channels LF and LR, so = CH+, sk = CH-; in channels LR and RF, so = CH-, SK = CH+.

In Permanent Diagnostic the table is the same, with only a difference concerning Open Load (*), which is not among the recognizable faults. Should an Open Load be present during the device's normal working, it would be detected at a subsequent Turn-on Diagnostic cycle (i.e. at the successive Car Radio Turn-on).

4.6 Faults availability

All the results coming from I²C bus, by read operations, are the consequence of measurements inside a defined period of time. If the fault is stable throughout the whole period, it will be sent out. This is true for DC diagnostic (Turn-on and Permanent), for Offset Detector, for AC Diagnostic (the low current sensor needs to be stable to confirm the Open tweeter).

To guarantee always resident functions, every kind of diagnostic cycles (Turn on, Permanent, Offset, AC) will be reactivate after any I²C reading operation. So, when the micro reads the I²C, a new cycle will be able to start, but the read data will come from the previous diag. cycle (i.e. The device is in Turn On state, with a short to Gnd, then the short is removed and micro reads I²C. The short to GND is still present in bytes, because it is the result of the previous cycle. If another I²C reading operation occurs, the bytes do not show the short). In general to observe a change in Diagnostic bytes, two I²C reading operations are necessary.



4.7 I²C programming/reading sequence

A correct turn on/off sequence respectful of the diagnostic timings and producing no audible noises could be as follows (after battery connection):

TURN-ON: (STANDBY OUT + DIAG ENABLE) --- 500 ms (min) --- MUTING OUT

TURN-OFF: MUTING IN --- 20 ms --- (DIAG DISABLE + STANDBY IN)

Car Radio Installation: DIAG ENABLE (write) --- 200 ms --- I²C read (repeat until All faults disappear).

AC TEST: FEED H.F. TONE -- AC DIAG ENABLE (write) --- WAIT > 3 CYCLES --- I^2C read (repeat I^2C reading until tweeter-off message disappears).

OFFSET TEST: Device in Play (no signal) -- OFFSET ENABLE - 30ms - I²C reading (repeat I²C reading until high-offset message disappears).



5 I²C bus interface

Data transmission from microprocessor to the TDA7566 and vice versa takes place through the 2 wires I^2C BUS interface, consisting of the two lines SDA and SCL (pull-up resistors to positive supply voltage must be connected).

5.1 Data validity

As shown by *Figure 25*, the data on the SDA line must be stable during the high period of the clock.

The HIGH and LOW state of the data line can only change when the clock signal on the SCL line is LOW.

5.2 Start and stop conditions

As shown by *Figure 26* a start condition is a HIGH to LOW transition of the SDA line while SCL is HIGH.

The stop condition is a LOW to HIGH transition of the SDA line while SCL is HIGH.

5.3 Byte format

Every byte transferred to the SDA line must contain 8 bits. Each byte must be followed by an acknowledge bit. The MSB is transferred first.

5.4 Acknowledge

The transmitter* puts a resistive HIGH level on the SDA line during the acknowledge clock pulse (see *Figure 27*). The receiver** the acknowledges has to pull-down (LOW) the SDA line during the acknowledge clock pulse, so that the SDA line is stable LOW during this clock pulse.

* Transmitter

- master (μP) when it writes an address to the TDA7566
- slave (TDA7566) when the μ P reads a data byte from TDA7566
- ** Receiver
 - slave (TDA7566) when the μ P writes an address to the TDA7566
 - master (µP) when it reads a data byte from TDA7566

Figure 25. Data validity on the I²C bus

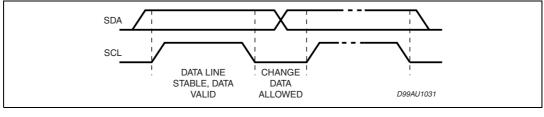
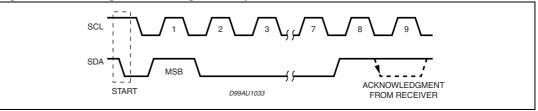








Figure 27. Timing acknowledge clock pulse





6 Software specifications

All the functions of the TDA7566 are activated by $\mathsf{I}^2\mathsf{C}$ interface.

The bit 0 of the "ADDRESS BYTE" defines if the next bytes are write instruction (from μ P to TDA7566) or read instruction (from TDA7566 to μ P).

Chip address

| D7 | | | | | | | D0 | |
|----|---|---|---|---|---|---|----|--------|
| 1 | 1 | 0 | 1 | 1 | 0 | 0 | Х | D8 Hex |

X = 0 Write to device

X = 1 Read from device

If R/W = 0, the μ P sends 2 "Instruction Bytes": IB1 and IB2.

Table 6. IB1

| Bit | Instruction decoding bit |
|-----|--|
| D7 | 0 |
| D6 | Diagnostic enable (D6 = 1) Diagnostic defeat (D6 = 0) |
| D5 | Offset Detection enable (D5 = 1) Offset Detection defeat (D5 = 0) |
| D4 | Front Channel Gain = $26dB (D4 = 0)$ Gain = $12dB (D4 = 1)$ |
| D3 | Rear Channel Gain = $26dB (D3 = 0)$ Gain = $12dB (D3 = 1)$ |
| D2 | Mute front channels (D2 = 0) Unmute front channels (D2 = 1) |
| D1 | Mute rear channels (D1 = 0) Unmute rear channels (D1 = 1) |
| D0 | CD 2% (D0 = 0) CD 10% (D0 = 1) |



| Table 7. | IB2 |
|----------|---|
| Bit | Instruction decoding bit |
| D7 | 0 |
| D6 | 0 |
| D5 | 0 |
| D4 | Standby on - Amplifier not working - (D4 = 0) Standby off - Amplifier working - (D4 = 1) |
| D3 | Power amplifier mode diagnostic (D3 = 0) Line driver mode diagnostic (D3 = 1) |
| D2 | Current detection diagnostic enabled (D2 = 1) Current detection diagnostic defeat (D2 = 0) |
| D1 | 0 |
| D0 | 0 |

If R/W = 1, the TDA7566 sends 4 "Diagnostics Bytes" to mP: DB1, DB2, DB3 and DB4.

| Table 8. DB1 | |
|--------------|---|
| Bit | Instruction decoding bit |
| D7 | Thermal warning active (D7 = 1) |
| D6 | Diag. cycle not activated or not terminated (D6 = 0) Diag. cycle terminated (D6 = 1) |
| D5 | Channel LF Current detection Output peak current < 250mA - Open load (D5 = 1) Output peak current > 500mA - Open load (D5 = 0) |
| D4 | Channel LF Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1) |
| D3 | Channel LF Normal load (D3 = 0) Short load (D3 = 1) |
| D2 | Channel LF Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Offset diag.: No output offset (D2 = 0) Output offset detection (D2 = 1) |
| D1 | Channel LF No short to Vcc (D1 = 0) Short to Vcc (D1 = 1) |
| D0 | Channel LF No short to GND (D1 = 0) Short to GND (D1 = 1) |

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| Table 9. | DB2 |
|----------|--|
| Bit | Instruction decoding bit |
| D7 | Offset detection not activated (D7 = 0) Offset detection activated (D7 = 1) |
| D6 | Current sensor not activated (D6 = 0) Current sensor activated (D6 = 1) |
| D5 | Channel LR Current detection Output peak current < 250mA - Open load (D5 = 1) Output peak current > 500mA - Open load (D5 = 0) |
| D4 | Channel LR Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1) |
| D3 | Channel LR Normal load (D3 = 0) Short load (D3 = 1) |
| D2 | Channel LR Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Permanent diag.: No output offset (D2 = 0) Output offset detection (D2 = 1) |
| D1 | Channel LR No short to Vcc (D1 = 0) Short to Vcc (D1 = 1) |
| D0 | Channel LR No short to GND (D1 = 0) Short to GND (D1 = 1) |



| Table 10. DB3 | |
|---------------|--|
| Bit | Instruction decoding bit |
| D7 | Standby status (= IB1 - D4) |
| D6 | Diagnostic status (= IB1 - D6) |
| D5 | Channel RF Current detection Output peak current < 250mA - Open load (D5 = 1) Output peak current > 500mA - Open load (D5 = 0) |
| D4 | Channel RF Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1) |
| D3 | Channel RF Normal load (D3 = 0) Short load (D3 = 1) |
| D2 | Channel RF Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Permanent diag.: No output offset (D2 = 0) Output offset detection (D2 = 1) |
| D1 | Channel RF No short to Vcc (D1 = 0) Short to Vcc (D1 = 1) |
| D0 | Channel RF No short to GND (D1 = 0) Short to GND (D1 = 1) |

| Table 10. D |
|-------------|
|-------------|





| Table 11. | DB4 |
|-----------|-----|
|-----------|-----|

| Bit | Instruction decoding bit |
|-----|--|
| ы | |
| D7 | X |
| D6 | x |
| D5 | Channel R Current detection Output peak current < 250 mA - Open load (D5 = 1) Output peak current > 500 mA - Open load (D5 = 0) |
| D4 | Channel RR Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1) |
| D3 | Channel RR Normal load (D3 = 0) Short load (D3 = 1) |
| D2 | Channel RR Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Permanent diag.: No output offset (D2 = 0) Output offset detection (D2 = 1) |
| D1 | Channel RR No short to Vcc (D1 = 0) Short to Vcc (D1 = 1) |
| D0 | Channel RR No short to GND (D1 = 0) Short to GND (D1 = 1) |

